## Application/Control No. Applicant(s)/Patent Under Reexamination 10/649,682 TANIZAKI, TETSUSHI Notice of References Cited Examiner Art Unit Page 1 of 1 Cynthia Britt 2138 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 714/733 US-5,173,906 12-1992 Dreibelbis et al. Α 02-2006 US-7,007,215 Kinoshita et al. 714/745 В US-С US-D US-Ε US-F US-G US-Н US-US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N O Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) "Testing Embedded Memories" by Chuck Plagmann Copyright 1997 Nelson Publishing Inc. http://www.evaluationengineering.com/archive/articles/1197mem.htm W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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